## Notice of References Cited Application/Control No. 10/700,908 Applicant(s)/Patent Under Reexamination RASPL, STEFAN Examiner Susan Y. Chen Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*	*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,636,862	10-2003	Lundahl et al.	707/101
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	Т	US			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
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## **NON-PATENT DOCUMENTS**

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